



MMG40H120XB6TN

1200V 40A PIM Module

RoHS Compliant

March 2011

PRELIMINARY

FEATURES

- High level of integration—only one power semiconductor module required for the whole drive
- Low saturation voltage and positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Industry standard package with insulated copper base plate and soldering pins for PCB mounting
- Temperature sense included



APPLICATIONS

- AC motor control
- Motion/servo control
- Inverter and power supplies

PIM Three Phase Input Rectifier

INVERTER SECTOR

ABSOLUTE MAXIMUM RATINGS

$T_c=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Values	Unit
IGBT				
V_{CES}	Collector - Emitter Voltage	$T_{vj}=25^\circ\text{C}$	1200	V
V_{GES}	Gate - Emitter Voltage		± 20	V
I_c	DC Collector Current	$T_c=25^\circ\text{C}$	55	A
		$T_c=80^\circ\text{C}$	40	A
I_{CM}	Repetitive Peak Collector Current	$t_p=1\text{ms}$	80	A
P_{tot}	Power Dissipation Per IGBT		195	W
Diode				
V_{RRM}	Repetitive Reverse Voltage	$T_{vj}=25^\circ\text{C}$	1200	V
$I_{F(AV)}$	Average Forward Current	$T_c=25^\circ\text{C}$	55	A
		$T_c=80^\circ\text{C}$	40	A
I_{FRM}	Repetitive Peak Forward Current	$t_p=1\text{ms}$	80	A
I^2t		$T_{vj}=125^\circ\text{C}, t=10\text{ms}, V_R=0\text{V}$	300	A^2s

INVERTER SECTOR**ELECTRICAL AND THERMAL CHARACTERISTICS** $T_c=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
IGBT						
$V_{GE(th)}$	Gate - Emitter Threshold Voltage	$V_{CE}=V_{GE}$, $I_c=1.5\text{mA}$	5.0	5.8	6.5	V
$V_{CE(sat)}$	Collector - Emitter Saturation Voltage	$I_c=40\text{A}$, $V_{GE}=15\text{V}$, $T_{vj}=25^\circ\text{C}$		1.8		V
		$I_c=40\text{A}$, $V_{GE}=15\text{V}$, $T_{vj}=125^\circ\text{C}$		2.05		V
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$, $T_{vj}=25^\circ\text{C}$			0.25	mA
		$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$, $T_{vj}=125^\circ\text{C}$			2	mA
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}$, $V_{GE}\pm 15\text{V}$, $T_{vj}=125^\circ\text{C}$	-400		400	nA
R_{Gint}	Integrated Gate Resistor			6.0		Ω
Q_{ge}	Gate Charge	$V_{CE}=600\text{V}$, $I_c=40\text{A}$, $V_{GE}=\pm 15\text{V}$		0.33		μC
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}$, $V_{GE}=0\text{V}$, $f=1\text{MHz}$		2.5		nF
C_{res}	Reverse Transfer Capacitance			0.11		nF
$t_{d(on)}$	Turn - on Delay Time	$V_{cc}=600\text{V}$, $I_c=40\text{A}$, $T_{vj}=25^\circ\text{C}$		90		ns
		$R_G=27\Omega$, $T_{vj}=125^\circ\text{C}$		90		ns
t_r	Rise Time	$V_{GE}=\pm 15\text{V}$, $T_{vj}=25^\circ\text{C}$		30		ns
		Inductive Load $T_{vj}=125^\circ\text{C}$		50		ns
$t_{d(off)}$	Turn - off Delay Time	$V_{cc}=600\text{V}$, $I_c=40\text{A}$, $T_{vj}=25^\circ\text{C}$		420		ns
		$R_G=27\Omega$, $T_{vj}=125^\circ\text{C}$		520		ns
t_f	Fall Time	$V_{GE}=\pm 15\text{V}$, $T_{vj}=25^\circ\text{C}$		70		ns
		Inductive Load $T_{vj}=125^\circ\text{C}$		90		ns
E_{on}	Turn - on Energy	$V_{cc}=600\text{V}$, $I_c=40\text{A}$, $T_{vj}=25^\circ\text{C}$		4.1		mJ
		$R_G=27\Omega$, $T_{vj}=125^\circ\text{C}$		5.8		mJ
E_{off}	Turn - off Energy	$V_{GE}=\pm 15\text{V}$, $T_{vj}=25^\circ\text{C}$		3.6		mJ
		Inductive Load $T_{vj}=125^\circ\text{C}$		4.2		mJ
I_{sc}	Short Circuit Current	$t_{psc}\leq 10\mu\text{s}$, $V_{GE}=15\text{V}$ $T_{vj}=125^\circ\text{C}$, $V_{cc}=900\text{V}$		160		A
R_{thJC}	Junction-to-Case Thermal Resistance (Per IGBT)				0.64	K /W
Diode						
V_F	Forward Voltage	$I_F=40\text{A}$, $V_{GE}=0\text{V}$, $T_{vj}=25^\circ\text{C}$		1.80		V
		$I_F=40\text{A}$, $V_{GE}=0\text{V}$, $T_{vj}=125^\circ\text{C}$		1.85		V
t_{rr}	Reverse Recovery Time	$I_F=40\text{A}$, $V_R=600\text{V}$ $di_F/dt=-400\text{A}/\mu\text{s}$ $T_{vj}=125^\circ\text{C}$		240		ns
I_{RRM}	Max. Reverse Recovery Current			35		A
E_{rec}	Reverse Recovery Energy			2.8		mJ
R_{thJCD}	Junction-to-Case Thermal Resistance (Per Diode)				1.0	K /W

DIODE-RECTIFIER SECTOR**ABSOLUTE MAXIMUM RATINGS***T_c=25°C unless otherwise specified*

Symbol	Parameter	Test Conditions	Values	Unit
V _{RRM}	Repetitive Reverse Voltage	T _{vj} =25°C	1600	V
I _{F(AV)}	Average Forward Current	T _c =80°C	40	A
I _{FSM}	Non-Repetitive Surge Forward Current	T _{vj} =45°C, t=10ms, 50Hz	320	A
		T _{vj} =45°C, t=8.3ms, 60Hz	350	A
I ² t		T _{vj} =45°C, t=10ms, 50Hz	512	A ² s
		T _{vj} =45°C, t=8.3ms, 60Hz	612	A ² s

DIODE-RECTIFIER SECTOR**ELECTRICAL AND THERMAL CHARACTERISTICS***T_c=25°C unless otherwise specified*

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V _F	Forward Voltage	I _F =40A , T _{vj} =25°C		1.2		V
		I _F =40A , T _{vj} =125°C		1.15		V
I _R	Reverse Leakage Current	V _R =1600V, T _{vj} =25°C			50	μA
		V _R =1600V, T _{vj} =125°C			1	mA
R _{thJCD}	Junction-to-Case Thermal Resistance (Per Diode)				1.0	K /W

BRAKE-CHOPPER SECTOR**ABSOLUTE MAXIMUM RATINGS***T_c=25°C unless otherwise specified*

Symbol	Parameter	Test Conditions	Values	Unit
IGBT				
V _{CES}	Collector - Emitter Voltage	T _{vj} =25°C	1200	V
V _{GES}	Gate - Emitter Voltage		±20	V
I _C	DC Collector Current	T _c =25°C	25	A
		T _c =80°C	15	A
I _{CM}	Repetitive Peak Collector Current	t _p =1ms	30	A
P _{tot}	Power Dissipation Per IGBT		105	W
Diode				
V _{RRM}	Repetitive Reverse Voltage	T _{vj} =25°C	1200	V
I _{F(AV)}	Average Forward Current	T _c =25°C	25	A
		T _c =80°C	15	A
I _{FRM}	Repetitive Peak Forward Current	t _p =1ms	30	A
I ² t		T _{vj} =125°C, t=10ms, V _R =0V	60	A ² s

BRAKE-CHOPPER SECTOR**ELECTRICAL AND THERMAL CHARACTERISTICS** $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
IGBT						
$V_{GE(th)}$	Gate - Emitter Threshold Voltage	$V_{CE}=V_{GE}$, $I_c=0.5\text{mA}$	5.0	5.8	6.5	V
$V_{CE(sat)}$	Collector - Emitter Saturation Voltage	$I_c=15\text{A}$, $V_{GE}=15\text{V}$, $T_{vj}=25^\circ\text{C}$		1.7		V
		$I_c=15\text{A}$, $V_{GE}=15\text{V}$, $T_{vj}=125^\circ\text{C}$		1.9		V
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$, $T_{vj}=25^\circ\text{C}$			50	μA
		$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$, $T_{vj}=125^\circ\text{C}$			1	mA
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}$, $V_{GE}\pm 15\text{V}$, $T_{vj}=125^\circ\text{C}$	-400		400	nA
R_{Gint}	Integrated Gate Resistor			0		Ω
Q_{ge}	Gate Charge	$V_{CE}=600\text{V}$, $I_c=15\text{A}$, $V_{GE}=\pm 15\text{V}$		0.15		μC
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}$, $V_{GE}=0\text{V}$, $f=1\text{MHz}$		1.1		nF
C_{res}	Reverse Transfer Capacitance			0.05		nF
$t_{d(on)}$	Turn - on Delay Time	$V_{cc}=600\text{V}$, $I_c=15\text{A}$, $T_{vj}=25^\circ\text{C}$		90		ns
		$R_G=62\ \Omega$, $T_{vj}=125^\circ\text{C}$		90		ns
t_r	Rise Time	$V_{GE}=\pm 15\text{V}$, $T_{vj}=25^\circ\text{C}$		25		ns
		Inductive Load $T_{vj}=125^\circ\text{C}$		30		ns
$t_{d(off)}$	Turn - off Delay Time	$V_{cc}=600\text{V}$, $I_c=15\text{A}$, $T_{vj}=25^\circ\text{C}$		420		ns
		$R_G=62\ \Omega$, $T_{vj}=125^\circ\text{C}$		520		ns
t_f	Fall Time	$V_{GE}=\pm 15\text{V}$, $T_{vj}=25^\circ\text{C}$		90		ns
		Inductive Load $T_{vj}=125^\circ\text{C}$		120		ns
E_{on}	Turn - on Energy	$V_{cc}=600\text{V}$, $I_c=15\text{A}$, $T_{vj}=25^\circ\text{C}$		1.4		mJ
		$R_G=62\ \Omega$, $T_{vj}=125^\circ\text{C}$		2.0		mJ
E_{off}	Turn - off Energy	$V_{GE}=\pm 15\text{V}$, $T_{vj}=25^\circ\text{C}$		1.0		mJ
		Inductive Load $T_{vj}=125^\circ\text{C}$		1.2		mJ
I_{sc}	Short Circuit Current	$t_{psc}\leq 10\ \mu\text{s}$, $V_{GE}=15\text{V}$ $T_{vj}=125^\circ\text{C}$, $V_{cc}=900\text{V}$		55		A
R_{thJC}	Junction-to-Case Thermal Resistance (Per IGBT)				1.2	K /W
Diode						
V_F	Forward Voltage	$I_F=15\text{A}$, $V_{GE}=0\text{V}$, $T_{vj}=25^\circ\text{C}$		1.65		V
		$I_F=15\text{A}$, $V_{GE}=0\text{V}$, $T_{vj}=125^\circ\text{C}$		1.75		V
t_{rr}	Reverse Recovery Time	$I_F=15\text{A}$, $V_R=600\text{V}$ $di_F/dt=-400\text{A}/\mu\text{s}$ $T_{vj}=125^\circ\text{C}$		150		ns
I_{RRM}	Max. Reverse Recovery Current			15		A
E_{rec}	Reverse Recovery Energy			0.6		mJ
R_{thJCD}	Junction-to-Case Thermal Resistance (Per Diode)				2.1	K /W

NTC SECTOR

CHARACTERISTIC VALUES

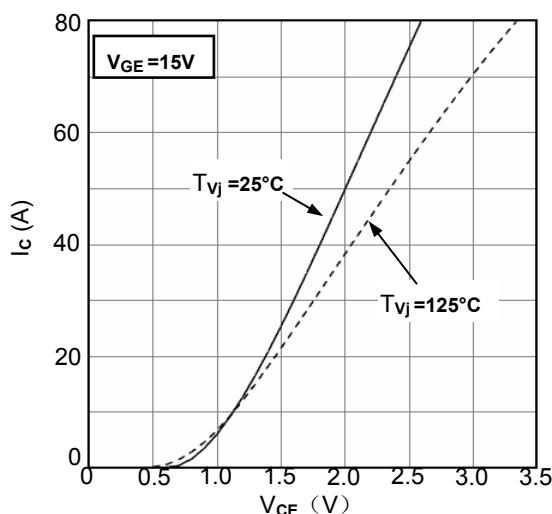
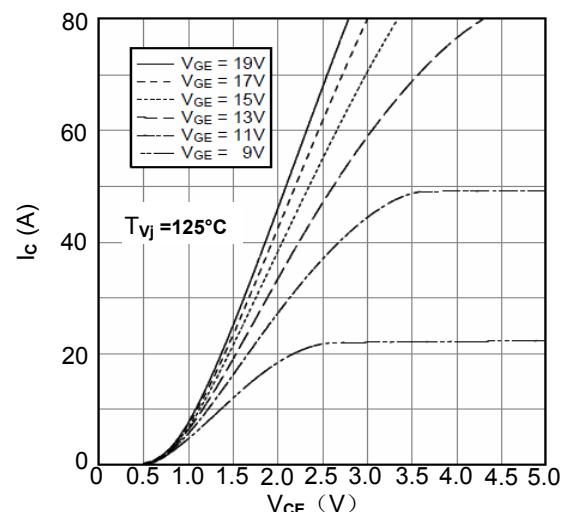
 $T_c=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Resistance	$T_c = 25^\circ\text{C}$		5		$\text{k}\Omega$
$B_{25/50}$				3375		K

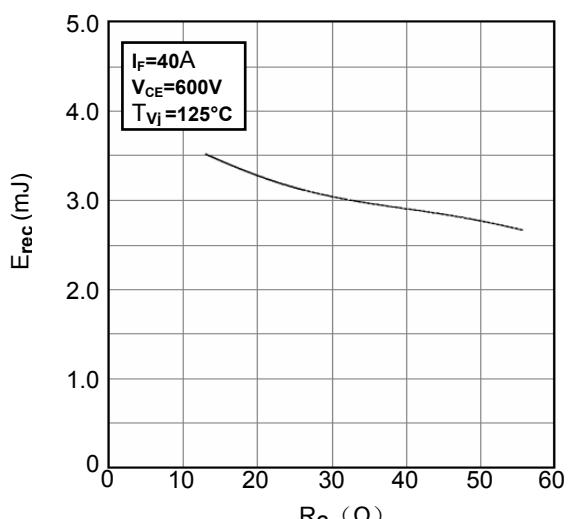
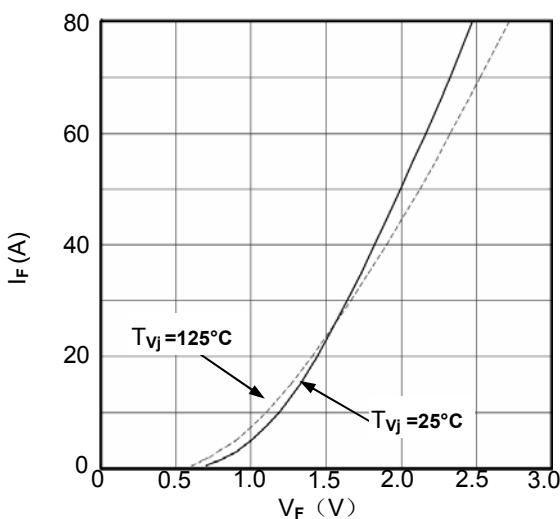
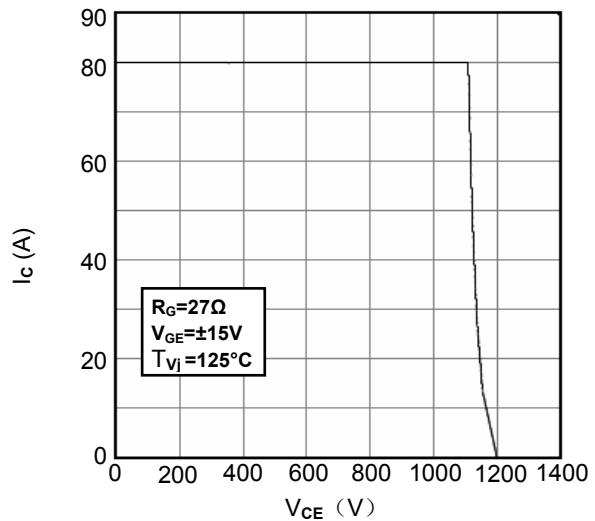
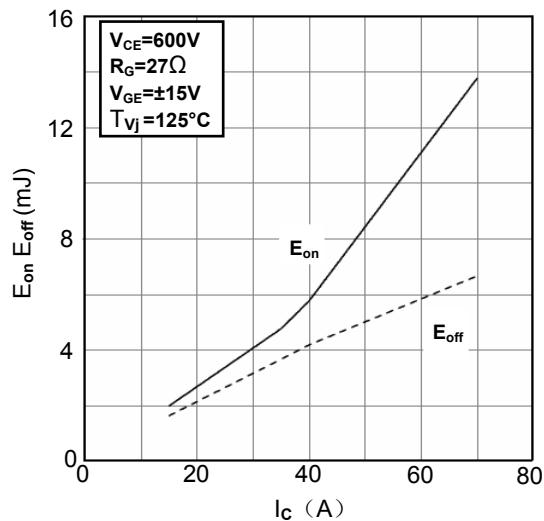
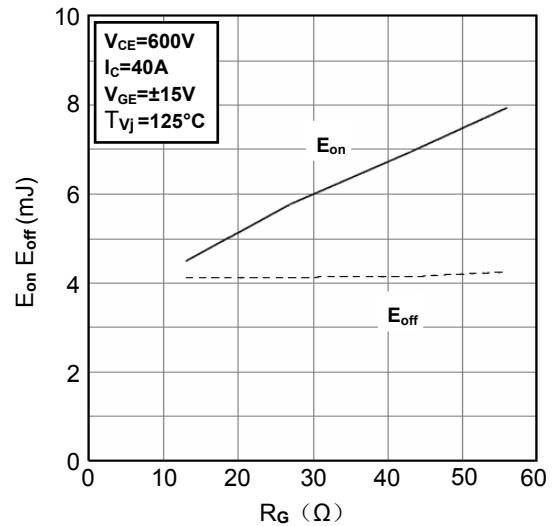
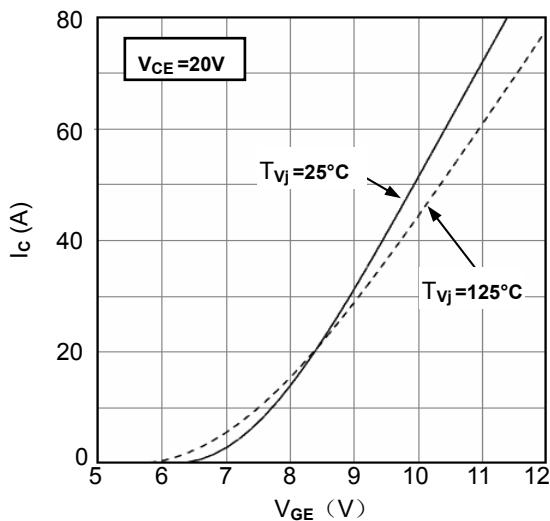
MODULE CHARACTERISTICS

 $T_c=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$T_{Vj\ max}$	Max. Junction Temperature				150	$^\circ\text{C}$
$T_{Vj\ op}$	Operating Temperature		-40		125	$^\circ\text{C}$
T_{stg}	Storage Temperature		-40		125	$^\circ\text{C}$
V_{isol}	Insulation Test Voltage	AC, t=1min		3000		V
CTI	Comparative Tracking Index		250			
M_d	Mounting Torque	Recommended (M5)	2.5		5	$\text{N} \cdot \text{m}$
Weight				180		g

Figure 1. Typical Output Characteristics
IGBT-inverterFigure 2. Typical Output Characteristics
IGBT-inverter

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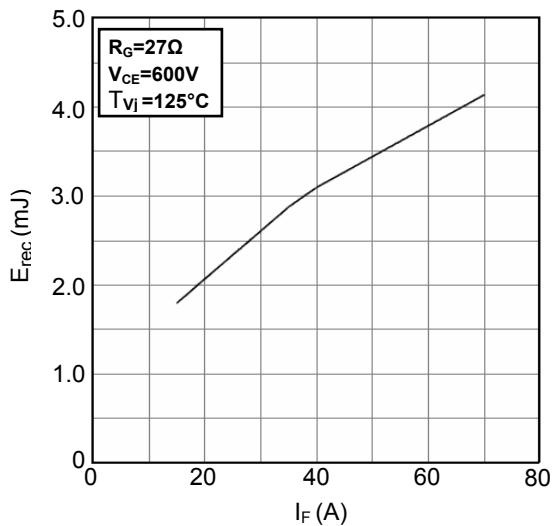


Figure 9. Switching Energy vs. Forward Current
Diode-inverter

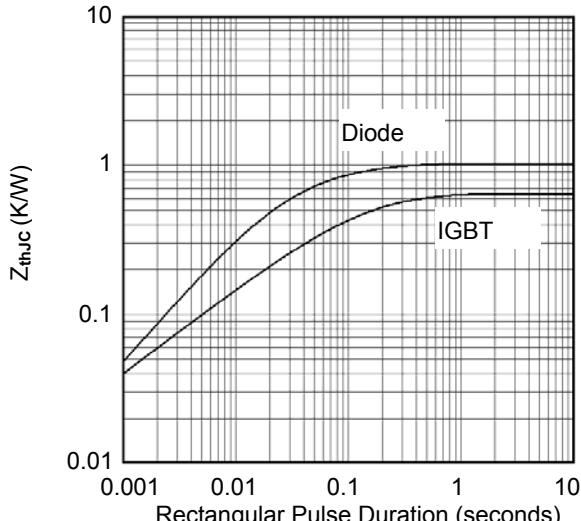


Figure 10. Transient Thermal Impedance of
Diode and IGBT-inverter

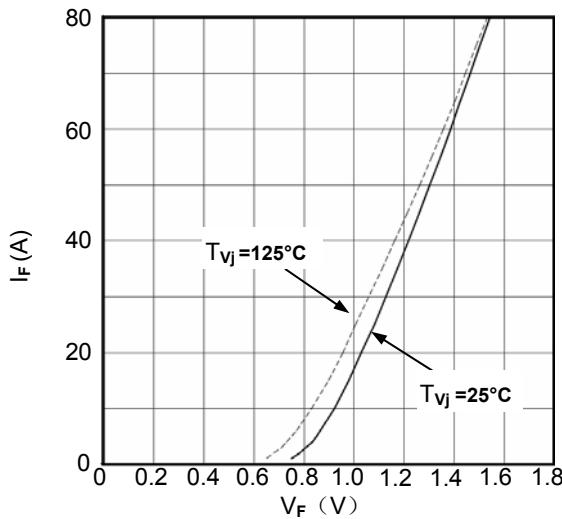


Figure 11. Diode Forward Characteristics
Diode- rectifier

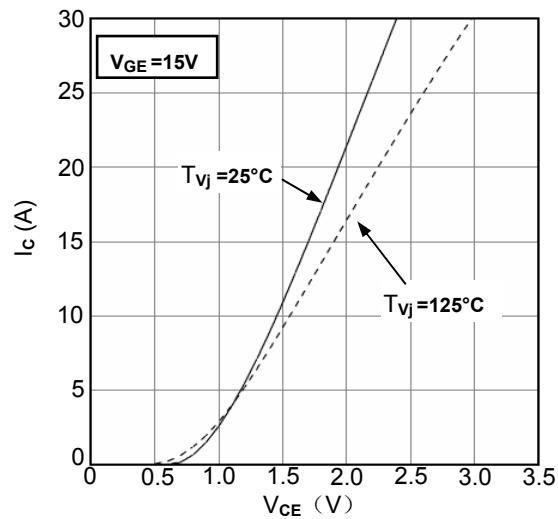


Figure 12. Typical Output Characteristics
IGBT- brake chopper

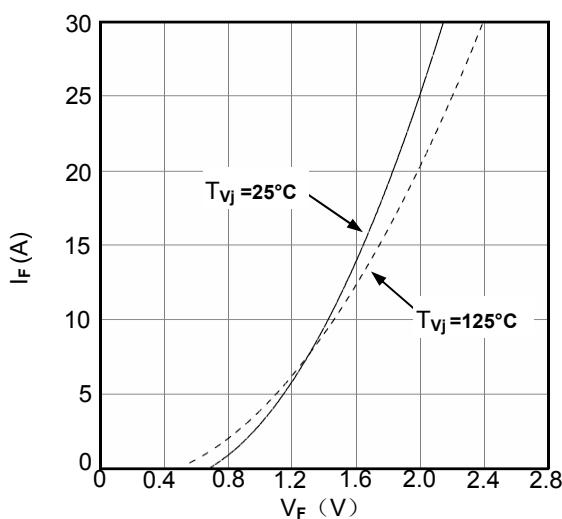


Figure 13. Diode Forward Characteristics
Diode - brake chopper

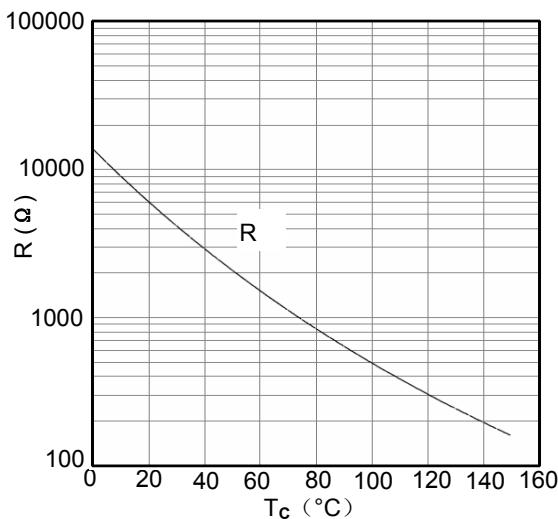


Figure 14. NTC Characteristics

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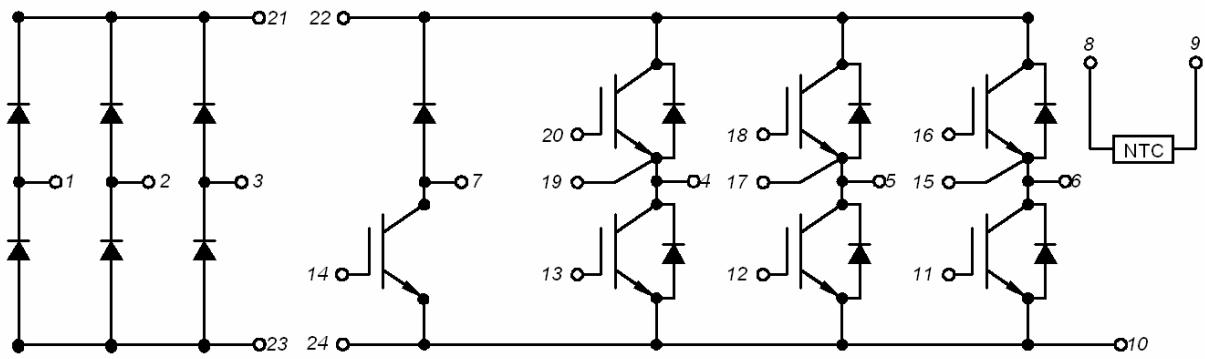
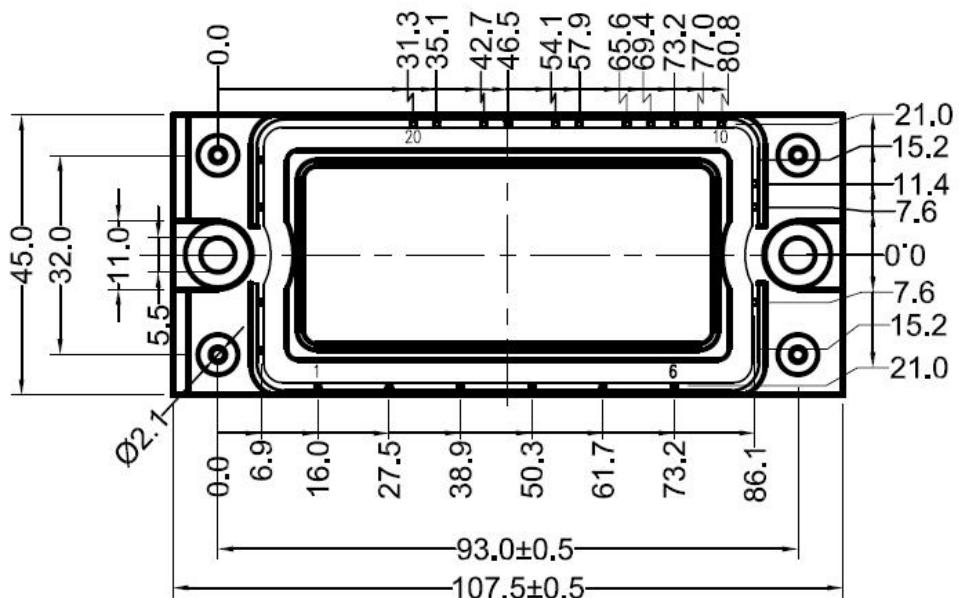
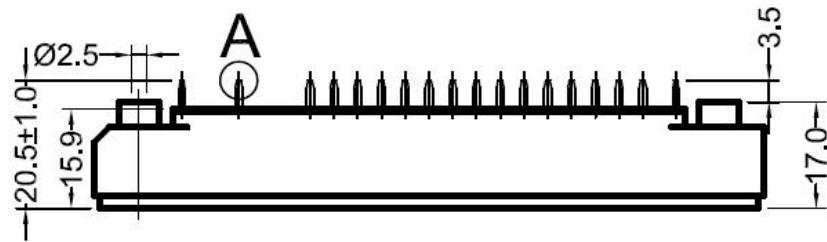


Figure15. Circuit Diagram



Dimensions (mm)
Figure16. Package Outline